Digital Integrated Circuit Testing using Transient Signal Analysis

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Abstract

A novel approach to testing CMOS digital circuits is presented that is based on an analysis of I_{DO} switching transients on the supply rails and voltage transients at selected test points. We present simulation and hardware experiments which show distinguishable characteristics between the transient waveforms of defective and non-defective devices. These variations are shown to exist for CMOS open drain and bridging defects, located both on and off of a sensitized path.

1.0 Introduction

Transient Signal Analysis (TSA) is a new parametric testing method for digital integrated circuits. In TSA, transients in both the voltage waveforms at selected test points as well as current transients on the power supply are analyzed to determine the presence of defects. TSA exploits the fact that the power supply is globally connected to a large fraction of the transistors in a CMOS digital integrated circuit. TSA is similar to power supply current (IDD) test methods in this way. Since power supply connections are unbuffered at the I/O pads, it is possible to measure the high frequency components of this signal without attenuation. Thus, the Ipp transients reflect the switching activity associated with the propagation of signals throughout the circuit. However, in larger circuits, the number of transistors which can simultaneously switch often makes it difficult to identify a defect using this single resource. TSA improves on defect detection capabilities of IDD test strategies by additionally monitoring the voltage transients at a set of test points as well as on IDD. The voltage test points are typically at or near the primary outputs of the device. By using a combination of voltage transients on test signal paths and IDD transients on the power supply, TSA can provide improved defect resolution while maintaining a high degree of process insensitivity when compared with other Ipp-based testing methods.

In this paper, we present results from four experiments conducted on actual devices with intentionally inserted bridging and open drain defects. In order to demonstrate the sensitivity advantage of TSA over logic testing, we have placed several bridging and open drain defects into separate versions of a test circuit and have conducted experiments using two-vector test sequences that do not generate logic errors at the test points. The results presented for the experiments show regional variations in the test point signals due to the presence of the defects.

The remainder of this paper is organized as follows. In Section 2 we present related research on device testing and the motivation for our research. Section 3 presents the results of hardware experiments conducted on devices with intentionally inserted bridging and open drain defects. Section 4 gives a summary and conclusions.

2.0 Background and Motivation

Device logic training analyzes the logical integrity of the device by using input test vectors which are a subset of all possible stimuli. However, these subsets are generated by techniques which are based on fault models that have been shown to be inadequate to detect all forms of CMOS defects [1][2]. Parametric testing strategies [3][4], on the other hand, are based on the analysis of a circuit's parametric properties, for example, peopagation delay, magnitude of supply current or transient response. While the algorithms for generating logic tests have been improved over time to handle more types of fault behaviors, parametric testing strategies offer intrinsically better solutions since they have been developed from the structural and electrical properties of CMOS circuits.

There are many types of parametric tests that have been proposed [5]. Recent research interest has focused primarily on three types; I_{DDQ} [6]. I_{DD} [7], and delay fault testing [8][9]. I_{DDQ} is based on the measurement of an IC's supply current when all nodes have stabilized to a quiescent value [10]. I_{DDQ} has been shown to be an effective diagnostic technique for CMOS bridging defects, but is of limited applicability for some types of CMOS open defects [11]. Although defect observability is significantly improved by the addition of I_{DDQ} to logic tests, I_{DDQ} is handicapped by the necessarily slow test vector application rates, the limited resolution achievable for large ICs and the restricted class of CMOS circuits to which it is applicable.

Several dynamic supply current I_{DD}-based approaches

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IC Test Using the Energy Consumption Ratio Wanli Jiang, 2000 **Integrated Circuits** Peter Shepherd, 1996-11-11 Integrated circuits have revolutionised the world of electronics and the associated areas of computing and communication In past years the tasks of designing manufacturing and testing these types of circuit were restricted to a few specialist engineers However within recent years the proliferation of computer tools and affordable access to IC manufacturing foundries has resulted in a substantial increase in the number of people designing ICs for the first time both in universities and colleges and in industry This book introduces the reader to all aspects of IC design manufacture and testing with a minimum of mathematics but with relevant examples at each stage It examines the overall design strategies the engineering trade offs and the advantages disadvantages and optimum applications of each available technology VLSI Testing Stanley Leonard Hurst, 1998 Hurst an editor at the Microelectronics Journal analyzes common problems that electronics engineers and circuit designers encounter while testing integrated circuits and the systems in which they are used and explains a variety of solutions available for overcoming them in both digital and mixed circuits Among his topics are faults in digital circuits generating a digital test pattern signatures and self tests structured design for testability testing structured digital circuits and microprocessors and financial aspects of testing The self contained reference is also suitable as a textbook in a formal course on the subject Annotation copyrighted by Book News Inc Portland OR **Fault Diagnosis of Analog** Integrated Circuits Prithviraj Kabisatpathy, Alok Barua, Satyabroto Sinha, 2006-01-13 System on Chip SOC having both digital and analog circuits has become increasingly prevalent in integrated circuit manufacturing industry Electronic tests are classified as digital analog and mixed signal Current methodologies for the testing of digital circuits are well developed In contrast methodologies for the testing of analog circuits remain relatively underdeveloped due to the complex nature of analog signals Compared to digital testing analog testing lags far behind in methodologies and tools and therefore demands substantial research and development effort Fault Diagnosis of Analog Integrated Circuits is a textbook for advanced undergraduate and graduate level students as well as practicing engineers. The objective of this book is to study the testing and fault diagnosis of analog and analog part of mixed signal circuits A background in analog integrated circuit artificial neural network is desirable but not essential The text covers the testing and fault diagnosis of both bipolar and Metal Oxide Semiconductor MOS circuits Fault model of the devices in analog domain has been introduced in the text The test stimulus generations are also discussed in details Experimental verification of some state of the art techniques has also been presented in the book It also contains problems that can be used as quiz or homework This book enables the reader to test an analog circuit that is implemented either in bipolar or MOS technology VLSI: Integrated Systems on Silicon Ricardo A. Reis, Luc Claesen, 2013-06-05 This book contains the papers that have been presented at the ninth Very Large Scale Integrated Systems conference VLSI 97 that is organized biannually by IFIP Working Group 10 5 It took place at Hotel Serra

Azul in Gramado Brazil from 26 30 August 1997 Previous conferences have taken place in Edinburgh Trondheim Vancouver Munich Grenoble and Tokyo The papers in this book report on all aspects of importance to the design of the current and future integrated systems. The current trend towards the realization of versatile Systems on a Chip require attention of embedded hardware software systems dedicated ASIC hardware sensors and actuators mixed analog digital design video and image processing low power battery operation and wireless communication The papers as presented in Jhis book have been organized in two tracks where one is dealing with VLSI System Design and Applications and the other presents VLSI Design Methods and CAD The following topics are addressed VLSI System Design and Applications Track VLSI for Video and Image Processing Microsystem and Mixed mode design Communication And Memory System Design Cow voltage Low power Analog Circuits High Speed Circuit Techniques Application Specific DSP Architectures VLSI Design Methods and CAD Track Specification and Simulation at System Level Synthesis and Technology Mapping CAD Techniques for Low Power Design Physical Design Issues in Sub micron Technologies Architectural Design and Synthesis Testing in Complex Mixed Analog and Electronic Design Automation for IC System Design, Verification, and Testing Luciano Lavagno, Igor L. Markov, Grant Martin, Louis K. Scheffer, 2017-12-19 The first of two volumes in the Electronic Design Automation for Integrated Circuits Handbook Second Edition Electronic Design Automation for IC System Design Verification and Testing thoroughly examines system level design microarchitectural design logic verification and testing Chapters contributed by leading experts authoritatively discuss processor modeling and design tools using performance metrics to select microprocessor cores for integrated circuit IC designs design and verification languages digital simulation hardware acceleration and emulation and much more New to This Edition Major updates appearing in the initial phases of the design flow where the level of abstraction keeps rising to support more functionality with lower non recurring engineering NRE costs Significant revisions reflected in the final phases of the design flow where the complexity due to smaller and smaller geometries is compounded by the slow progress of shorter wavelength lithography New coverage of cutting edge applications and approaches realized in the decade since publication of the previous edition these are illustrated by new chapters on high level synthesis system on chip SoC block based design and back annotating system level models Offering improved depth and modernity Electronic Design Automation for IC System Design Verification and Testing provides a valuable state of the art reference for electronic design automation EDA students researchers and professionals IEEE VLSI Test Symposium ,2004 **18th IEEE VLSI Test Symposium** ,2000 Proceedings of a spring 2000 symposium highlighting novel ideas and approaches to current and future problems related to testing of electronic circuits and systems Themes are microprocessor test validation low power BIST and scan technology trends scan related approaches defect driven techniques and system on chip test techniques Other subjects are analog test techniques temperature and process drift issues test compaction and design validation analog BIST and functional test and verification issues Also covered are STIL

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